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Research progress on long lifetime MCP-PMT

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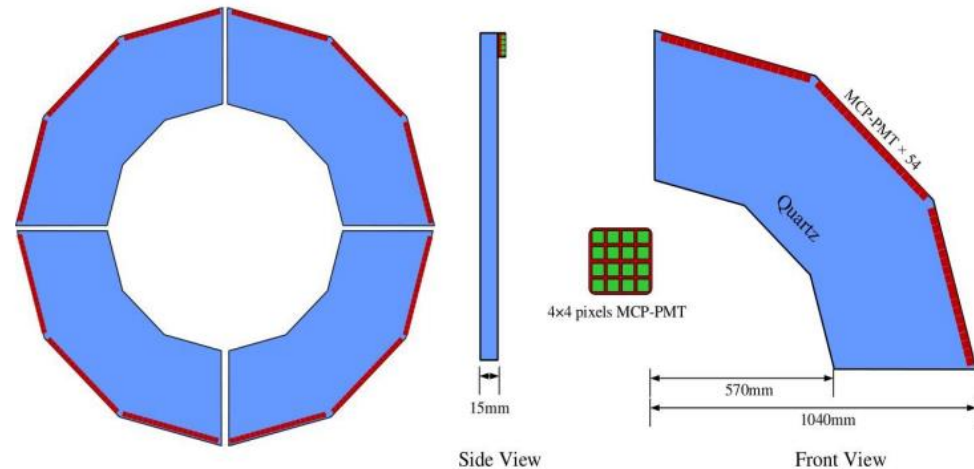
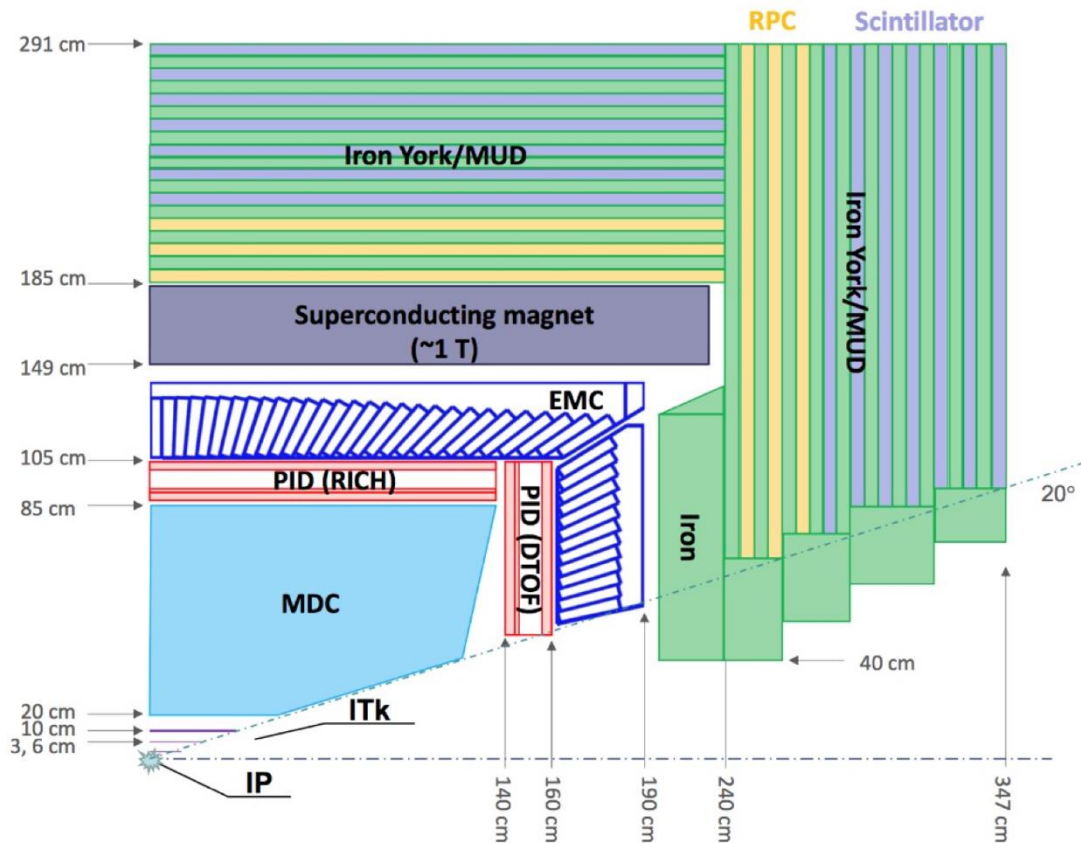
20/11/2024

STCF PID (DTOF)



MCP-PMT requirements

- 4x4 anodes
- Gain > 1E6
- TTS < 100 ps
- QE > 20%
- Lifetime > ten years (IAC > 10C/cm²)
- High rate capability
-



DTOF: DIRC-like TOF

MCP-PMTs by XIOPM



20 inch MCP-PMT



Φ18mm Fast/Gated MCP-PMT



Φ25mm Fast/Gated MCP-PMT



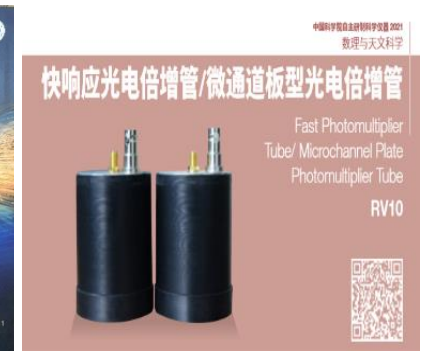
Φ50mm Large current MCP-PMT



Φ80mm Large current MCP-PMT



MCP-maPMT Long lifetime MCP-maPMT

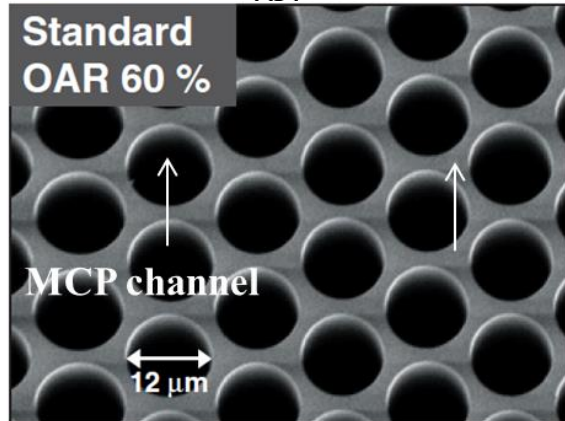
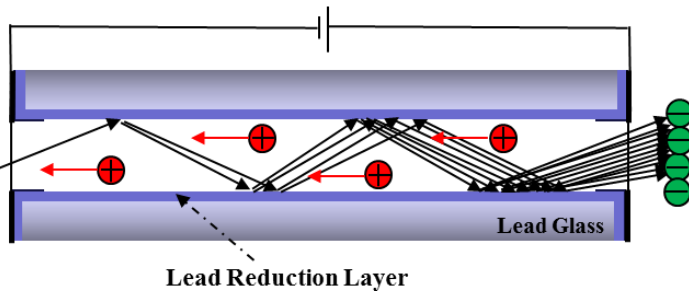


Microchannel plate



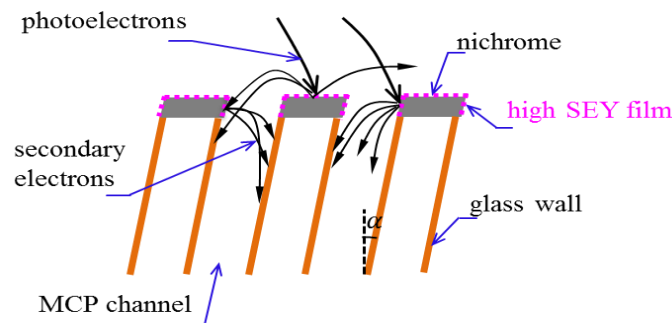
Conventional MCP

- Made of lead glass
- Collection efficiency ~60%
- Gain from lead glass
- Maximum SEE yield ~3



ALD-MCP based on lead glass

- Coating Al₂O₃/MgO on the lead glass MCP input surface and channel
- Maximum SEE yield over 4
- Gain mainly from ALD-layer
- Collection efficiency improved to ~100%
- Improve CE of 20" MCP-PMT for JUNO
- Lifetime extended

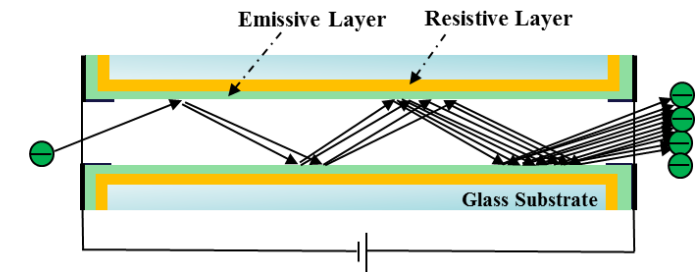


20 inch MCP-PMT for JUNO

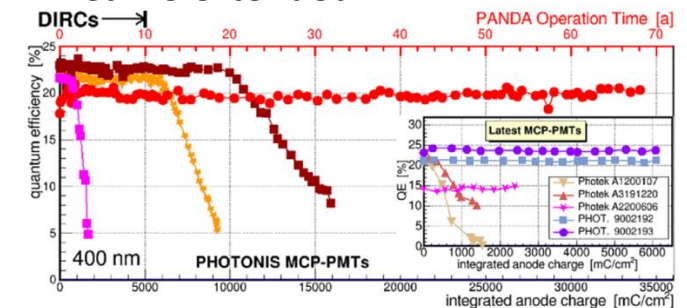


ALD-MCP based on borosilicate glass

- Lead free
- ALD coating resistive layer and emissive layer
- Gain resulted from ALD-Layer
- Maximum SEE over 4
- Lifetime extended



Lifetime extended



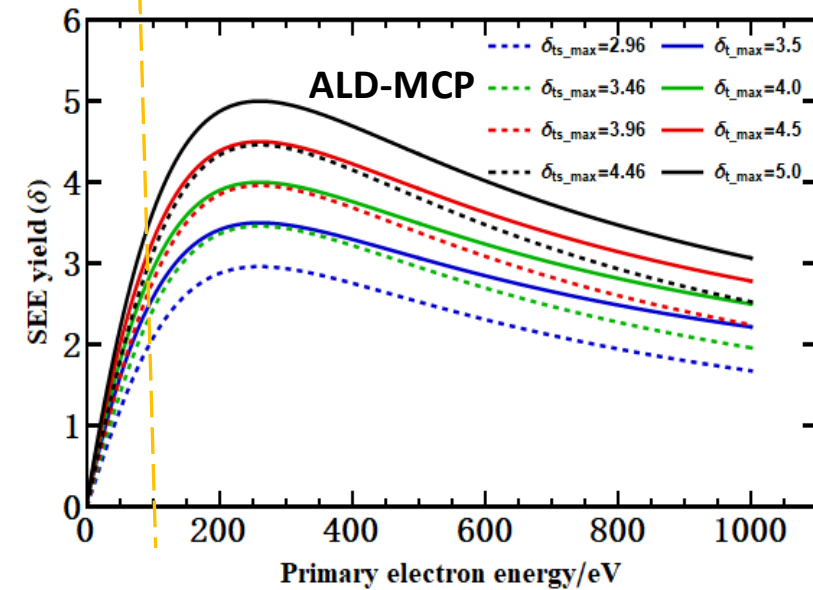
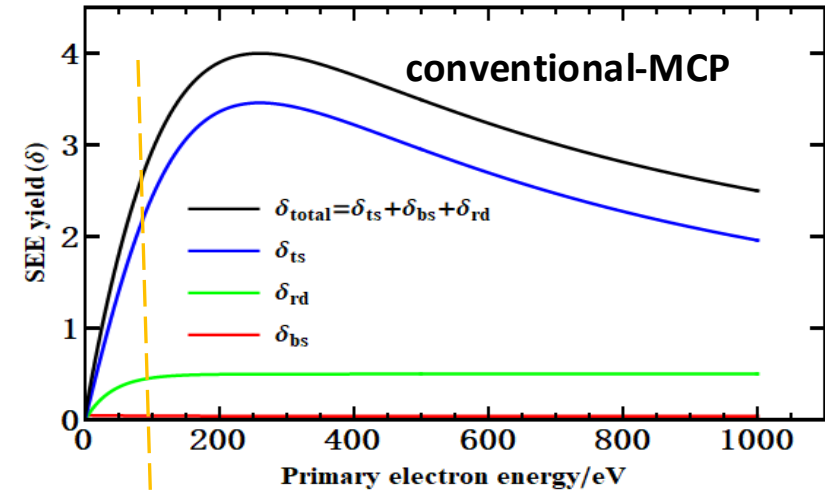
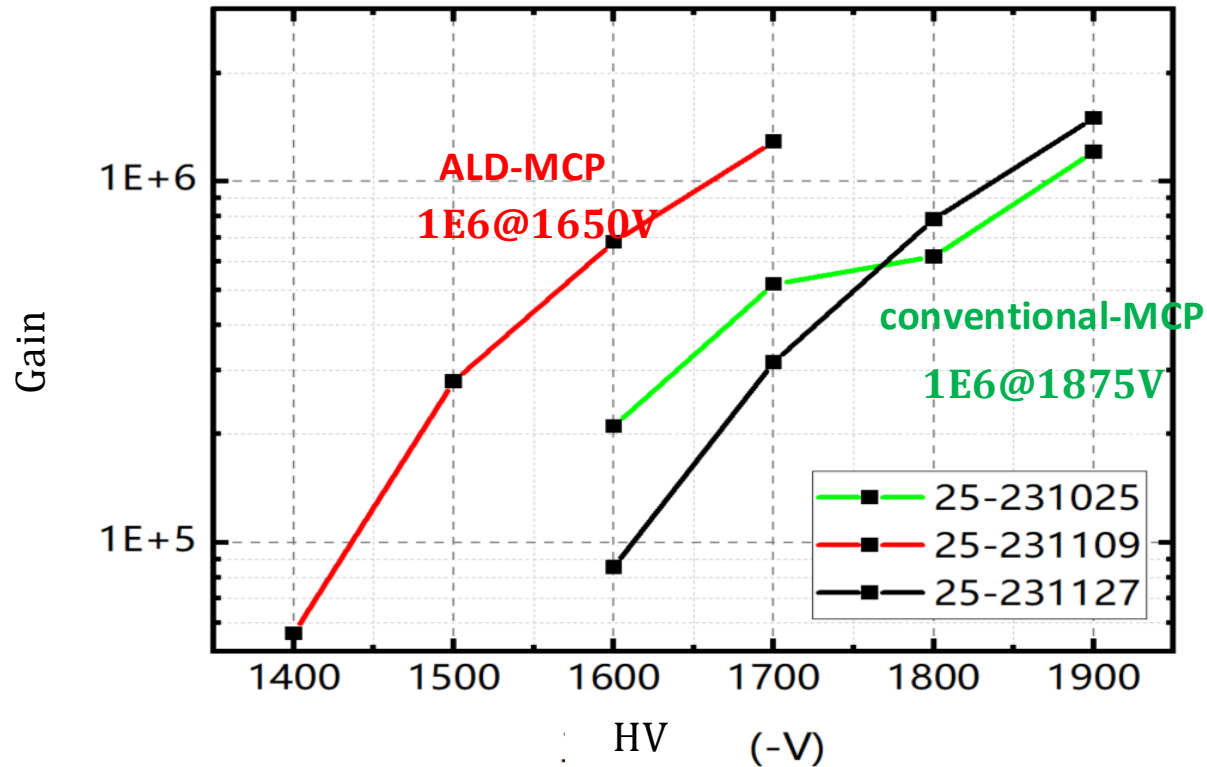
gain



ALD-MCP

Higher gain at lower HV

- Higher SEE yield for ALD-MCP



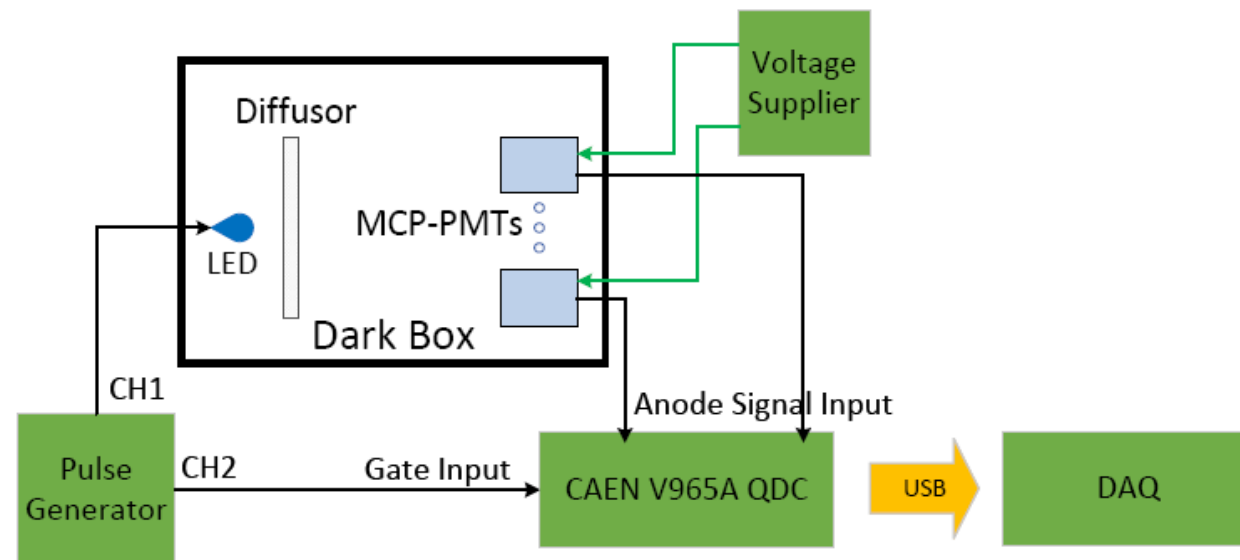


Factors affecting the lifetime of MCP-PMT ?

- Single anode MCP-PMTs produced for lifetime study
 - 25 mm diameter
 - MCPs with and without ALD layer
 - ALD layer of 1 nm, 4.5 nm, 6nm thickness
 - MCP scrubbed amount of 0.43~0.75 $\mu\text{A}\cdot\text{h}/\text{cm}^2$
 - Worked at gain of $5\text{e}5\sim 1\text{e}6$
- Light source
 - LED driven by a pulse generator
 - 10 ns pulse width
 - 405 nm wavelength



Integrated anode charge : $IAC = \sum \bar{q} \cdot t \cdot f$



lifetime



□ Influence of ALD film thickness

Lifetime@6 nm > 4.5 nm > 1nm > none

□ Influence of scrubbing amount

Lifetime: @0.75 $\mu\text{A}\cdot\text{h}/\text{cm}^2$ > 0.52 $\mu\text{A}\cdot\text{h}/\text{cm}^2$ > 0.43 $\mu\text{A}\cdot\text{h}/\text{cm}^2$

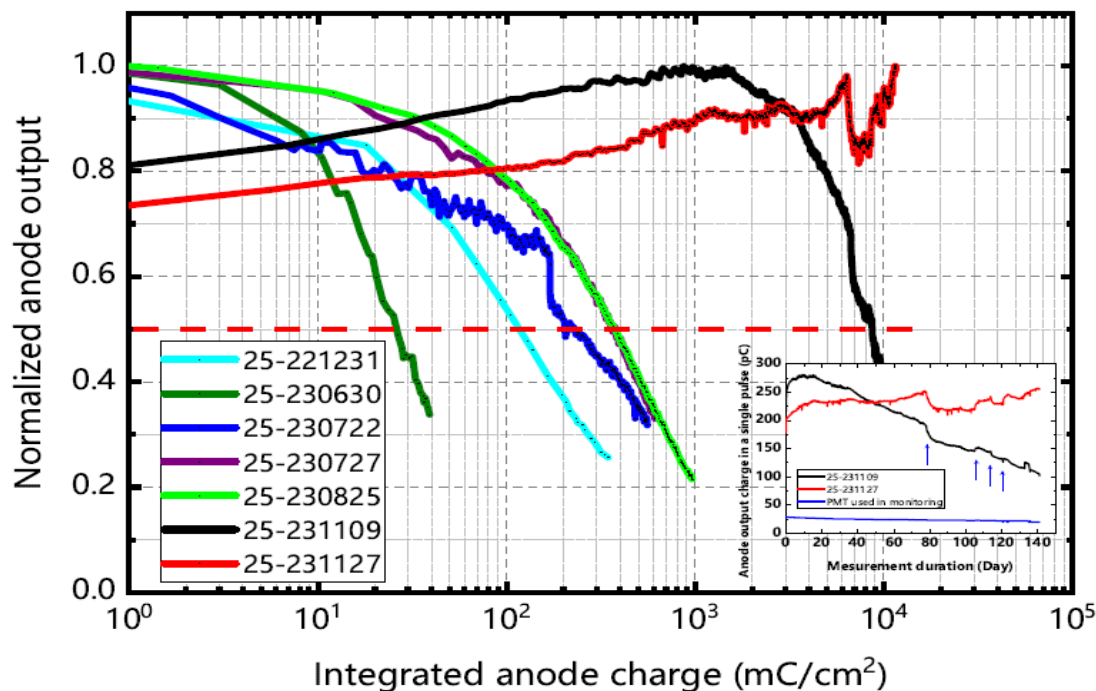


Table 2. IAC at 50% anode output degradation for the MCP-PMTs.

ID	Thickness of the ALD-layer (nm)	Electron scrubbing dosage ($\mu\text{A}\cdot\text{h}/\text{cm}^2$)	IAC at 50% degradation (mC/cm^2)
25-221231	1	0.43	117
25-230630	None	0.43	26
25-230722	1	0.52	230
25-230727	1	0.75	373
25-230825	1	0.75	373
25-231109	4.5	0.75	8800
25-231127	6	0.75	> 11,000

IAC over 11 C/cm²

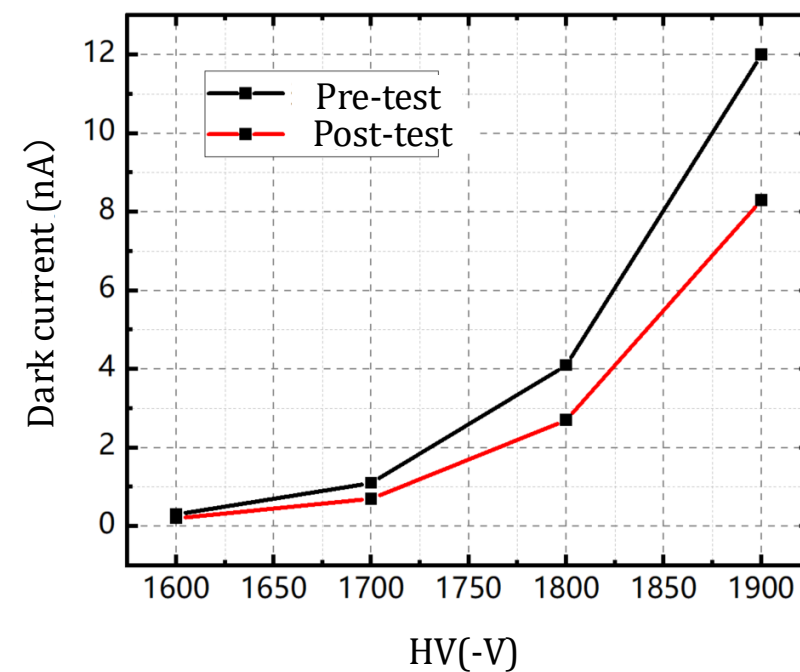
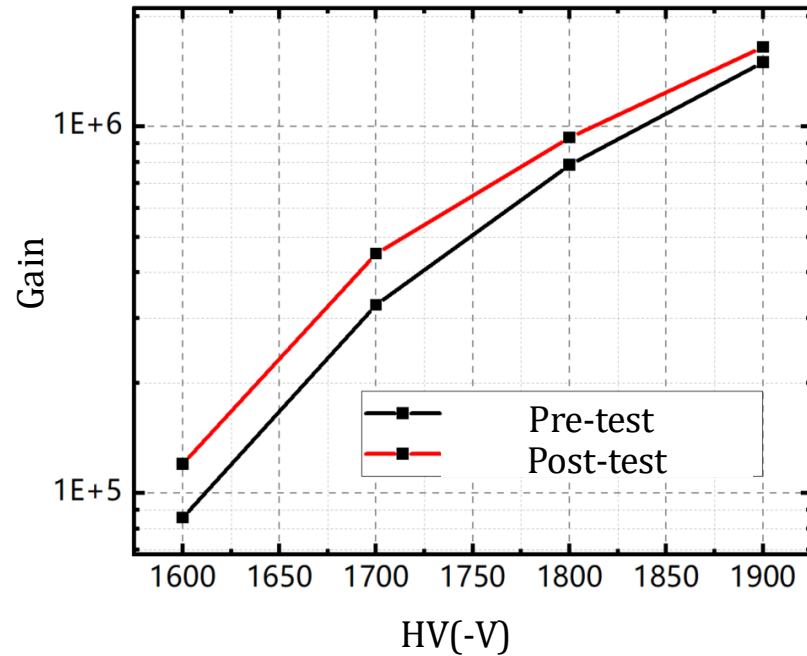
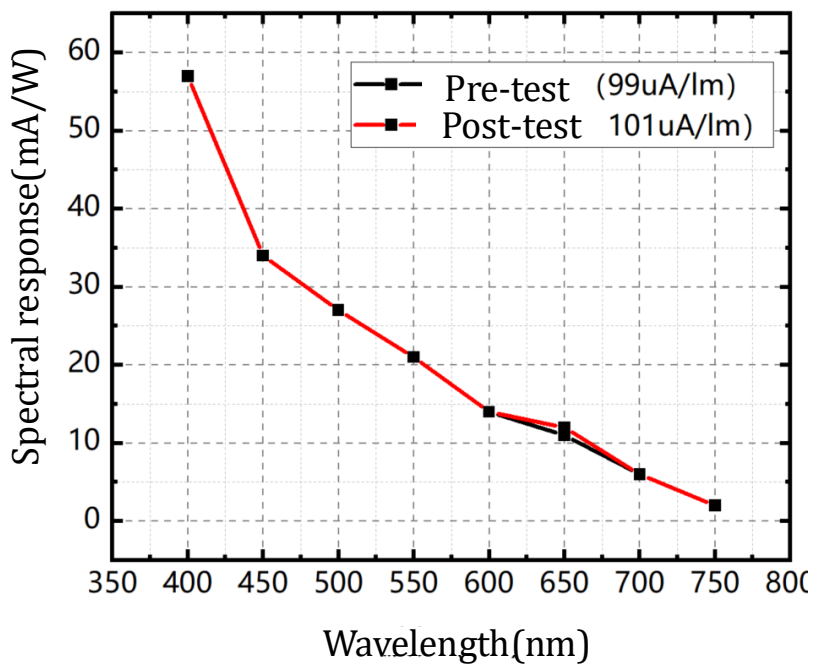
lifetime



Performances before and after lifetime tests

25-231127 with IAC over 11 C/cm²

none degradation on photocathode and MCP



Lifetime

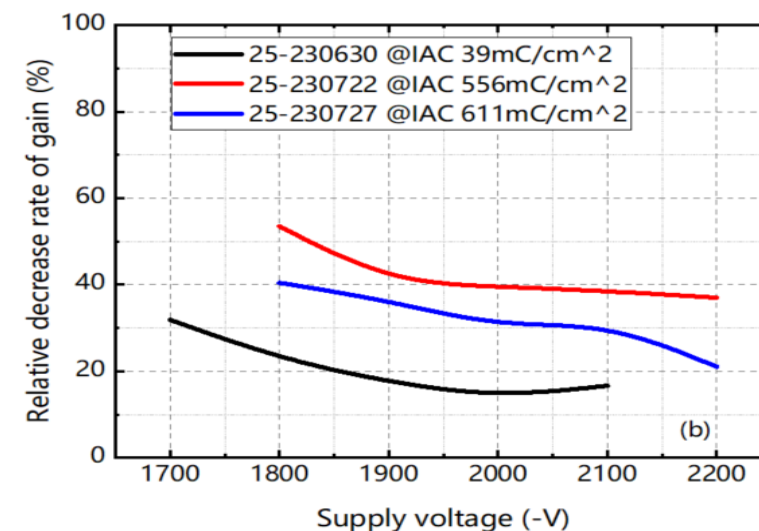
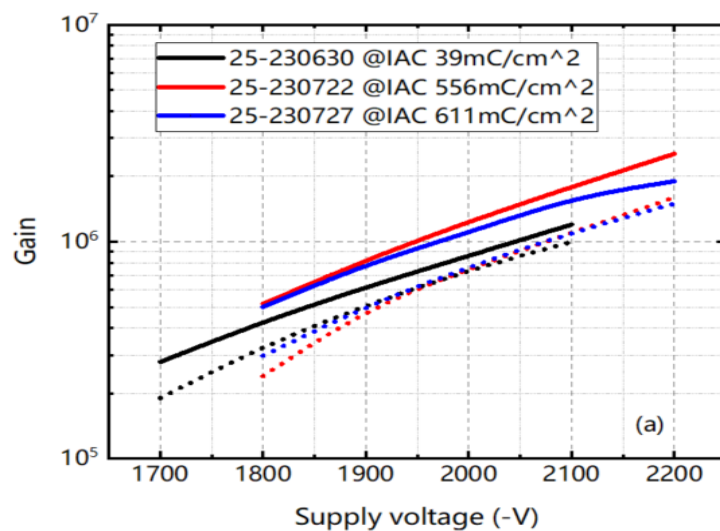
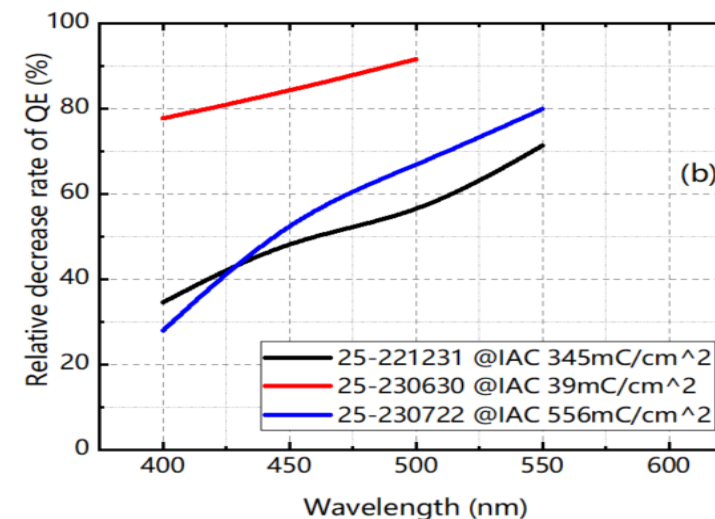
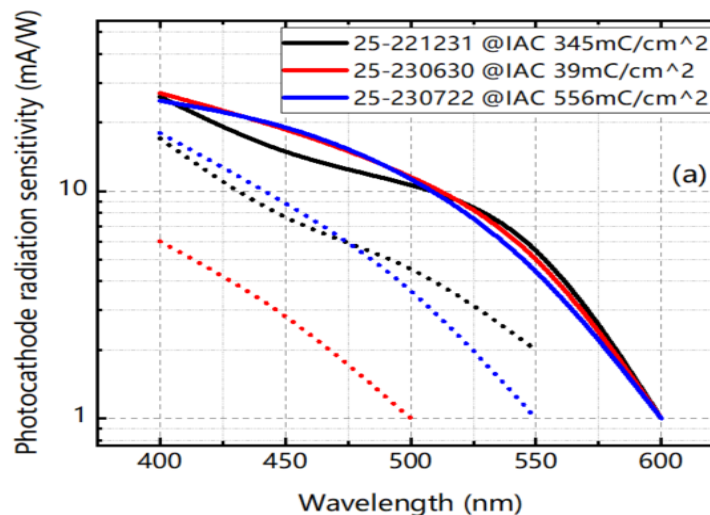


Performances before and after lifetime tests

QE decreases more at longer wavelengths

Table 2. IAC at 50% anode output degradation for the MCP-PMTs.

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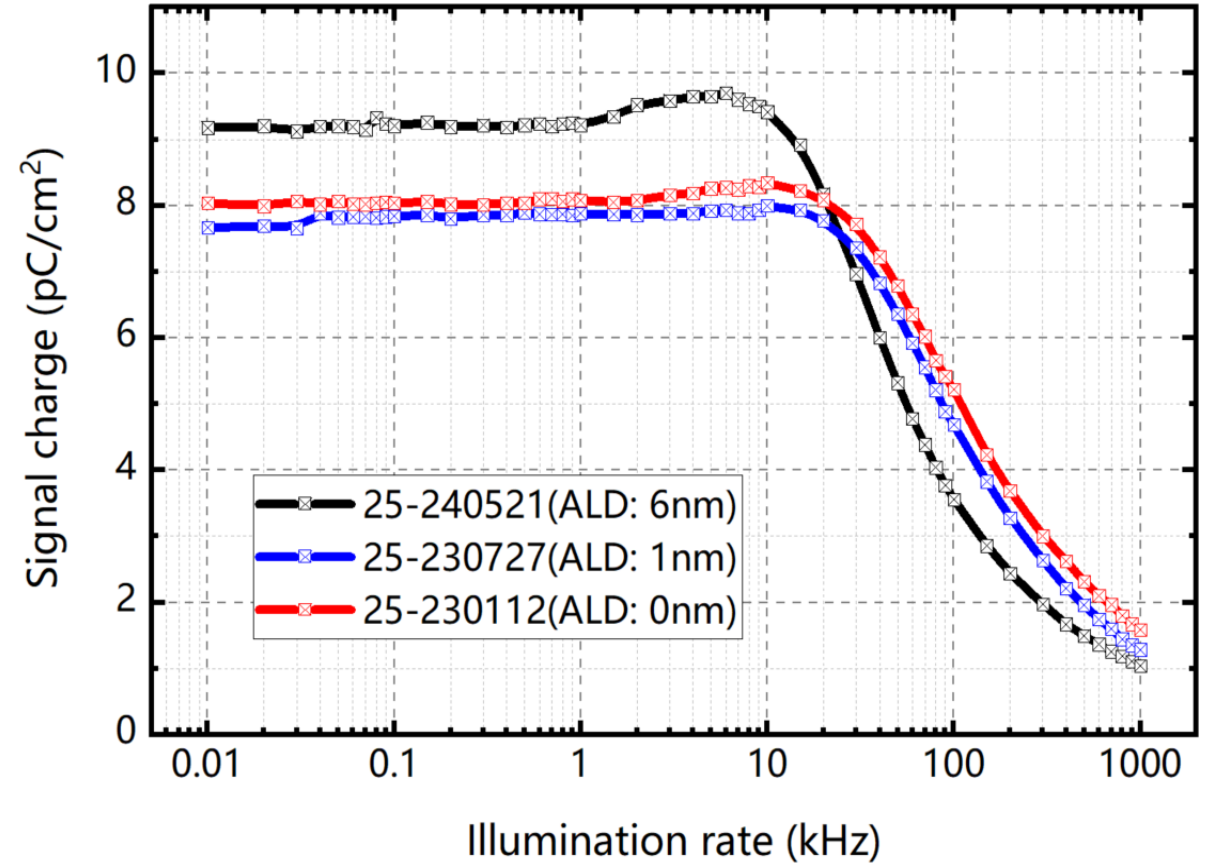
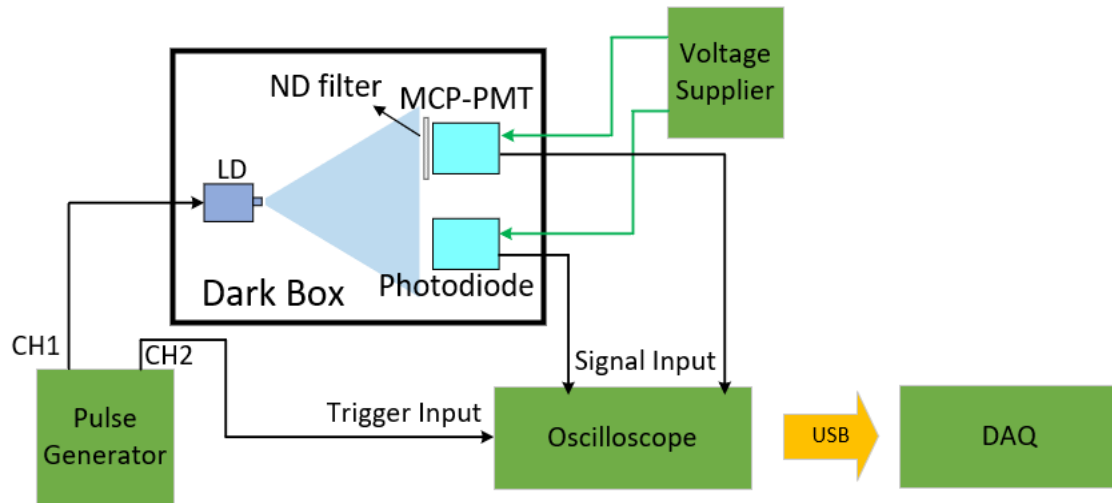


Rate capability



● measurement setup

- Single-anode MCP-PMTs with 25 mm diameter
- LD driven by a pulse generator
- 10 ns pulse width
- ~3500 photons/cm²/pulse

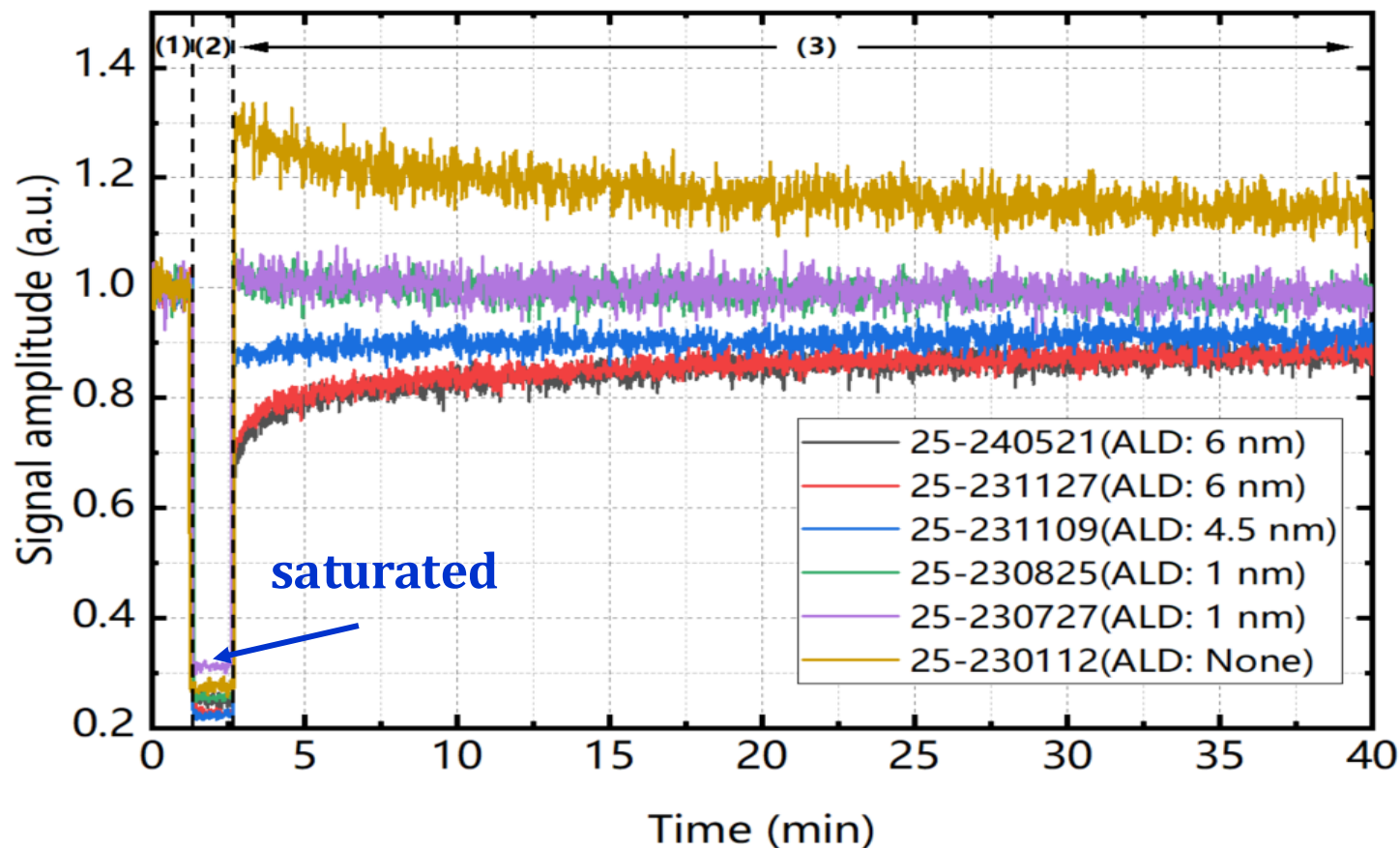


Recovery behavior



ALD film effect

- MCP-PMTs with different thickness of ALD film operated at $1E5$ gain
- illuminated by LD at rates of 10 Hz、500 kHz、10 Hz for 84 seconds to be saturated



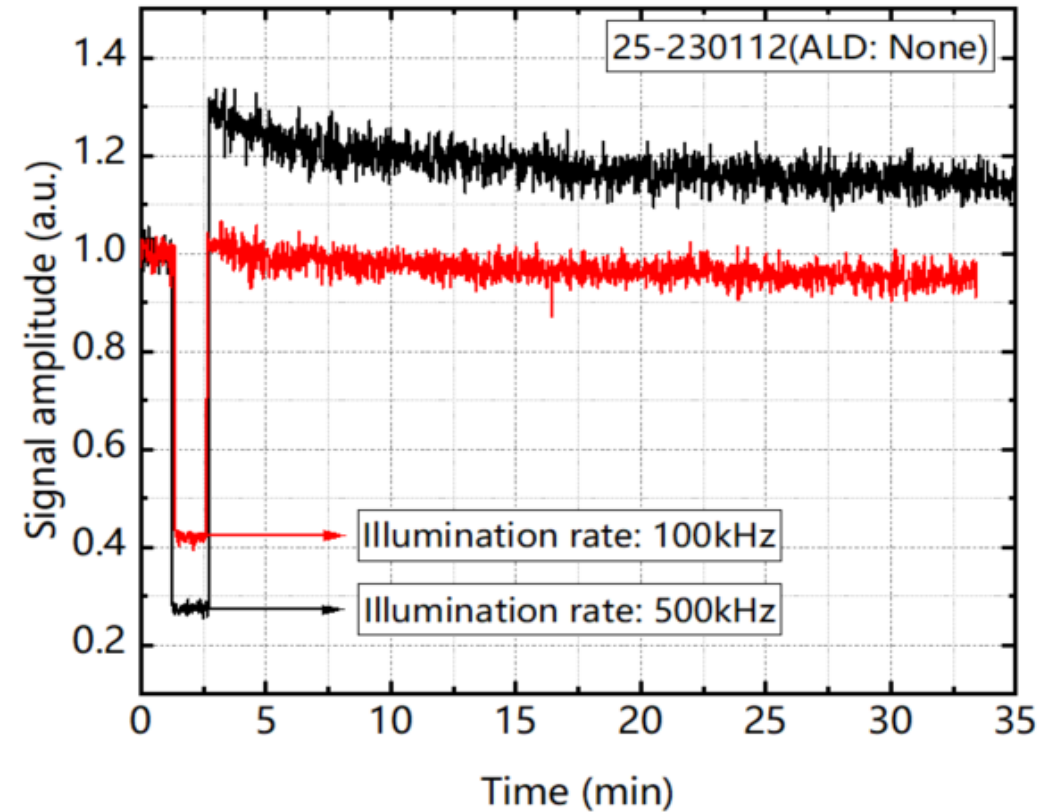
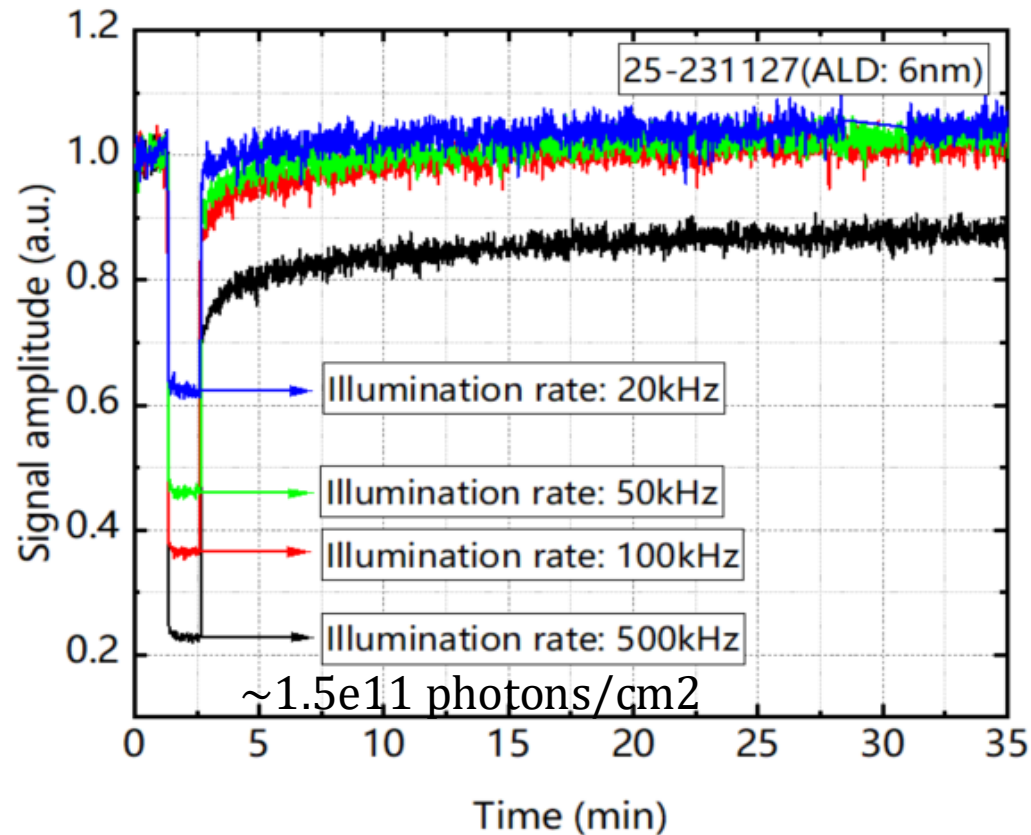
- Longer recovery time for thicker ALD-layer MCP
- Super linearity for none-ALD MCP ?

Recovery behavior



□ Illumination rate effect

- The greater the degree of saturation, the slower the recovery
- Super linearity is worse at higher rate for none-ALD MCP



Recovery behavior

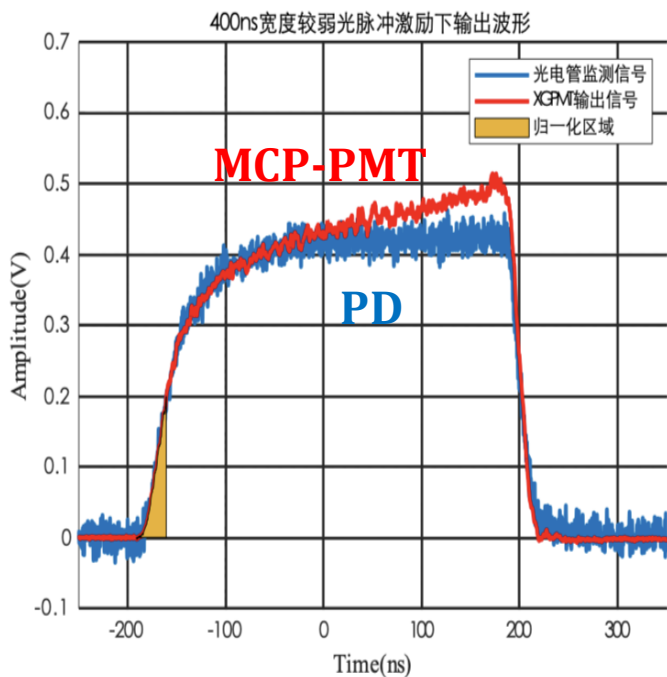


Super linearity for none-ALD MCP

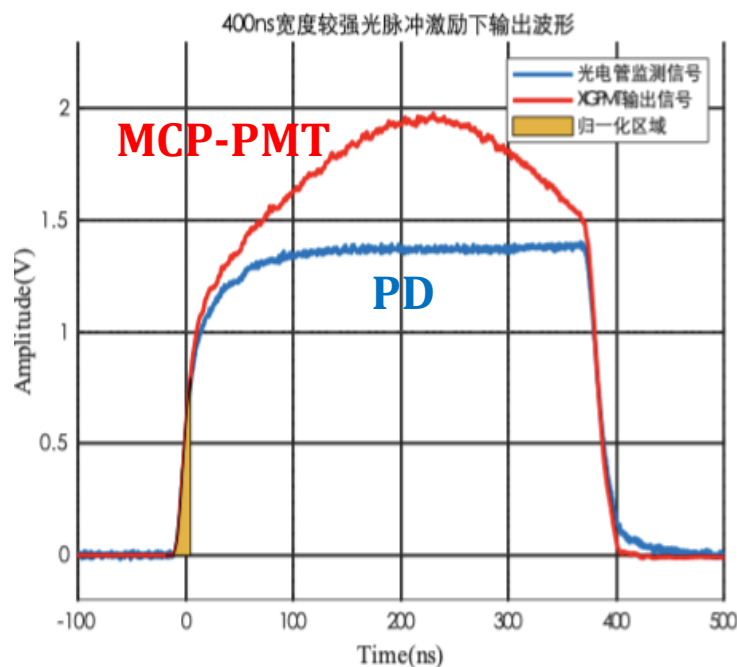
- Single-anode MCP-PMT with 50 mm diameter
- PD for monitoring light source
- Super linearity is worse for stronger illumination



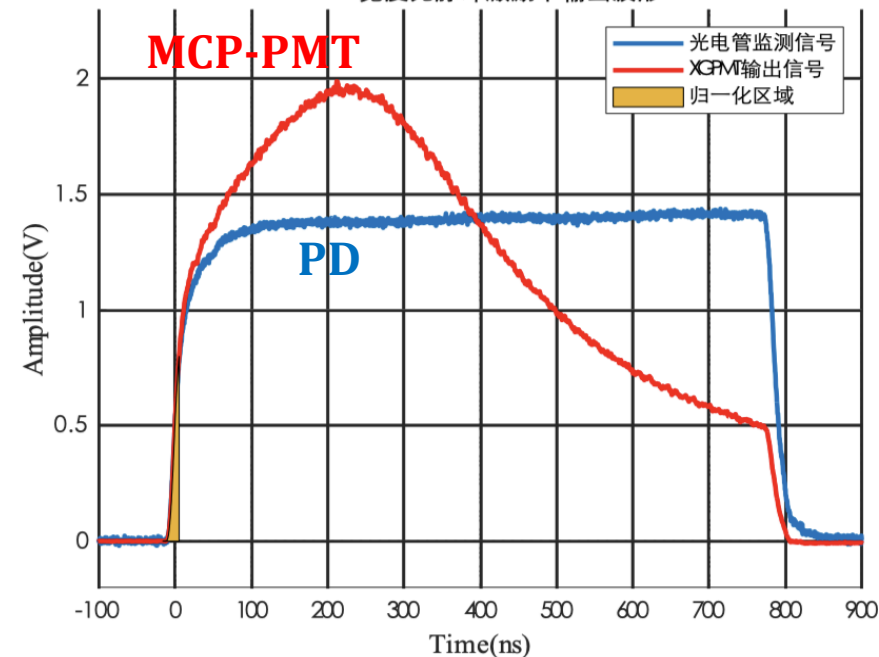
Light source 400ns, 0.4V



400ns, 1.4V



800ns宽度光脉冲激励下输出波形

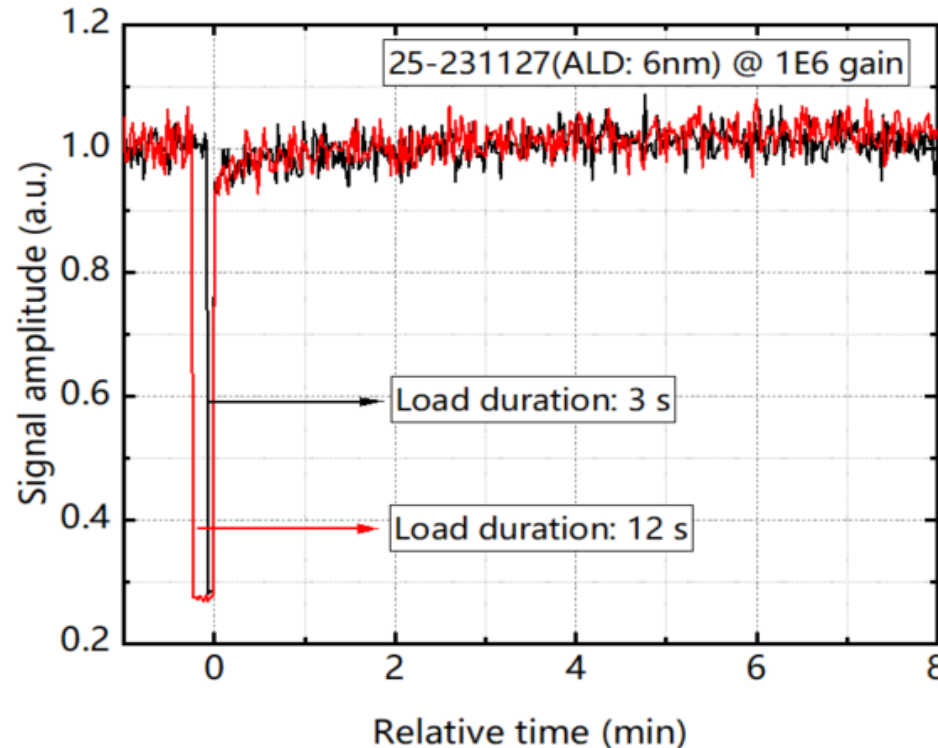
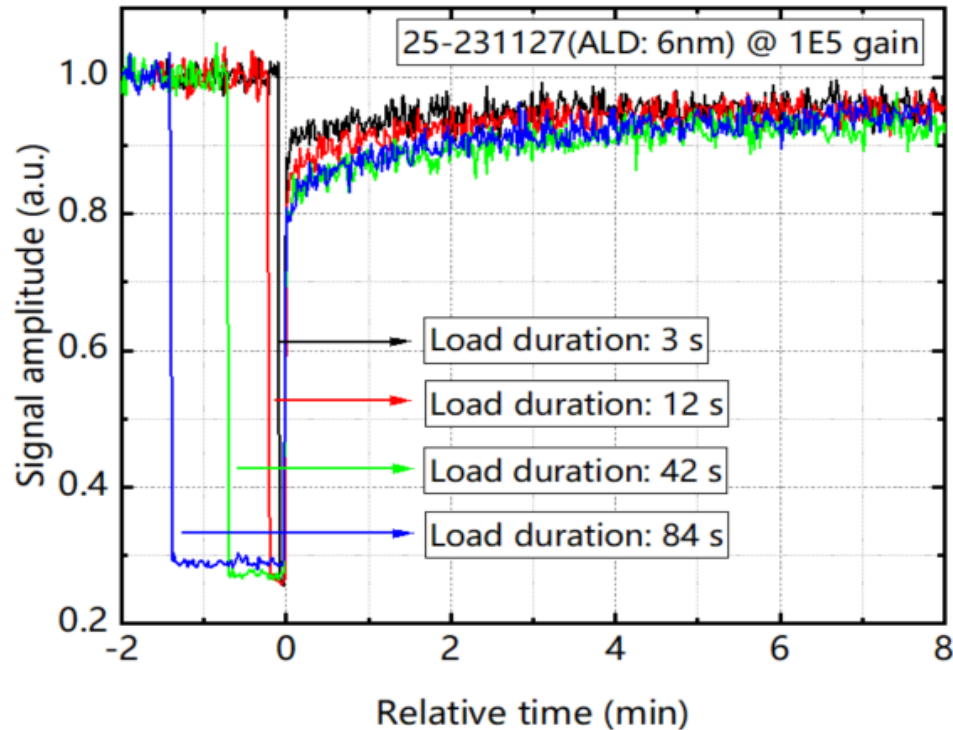


Recovery behavior



□ Saturation duration effect

- The longer the saturation duration, the slower the recovery.
- When the saturation duration exceeds a certain value(e.g. 42s), the recovery behavior no longer changes.

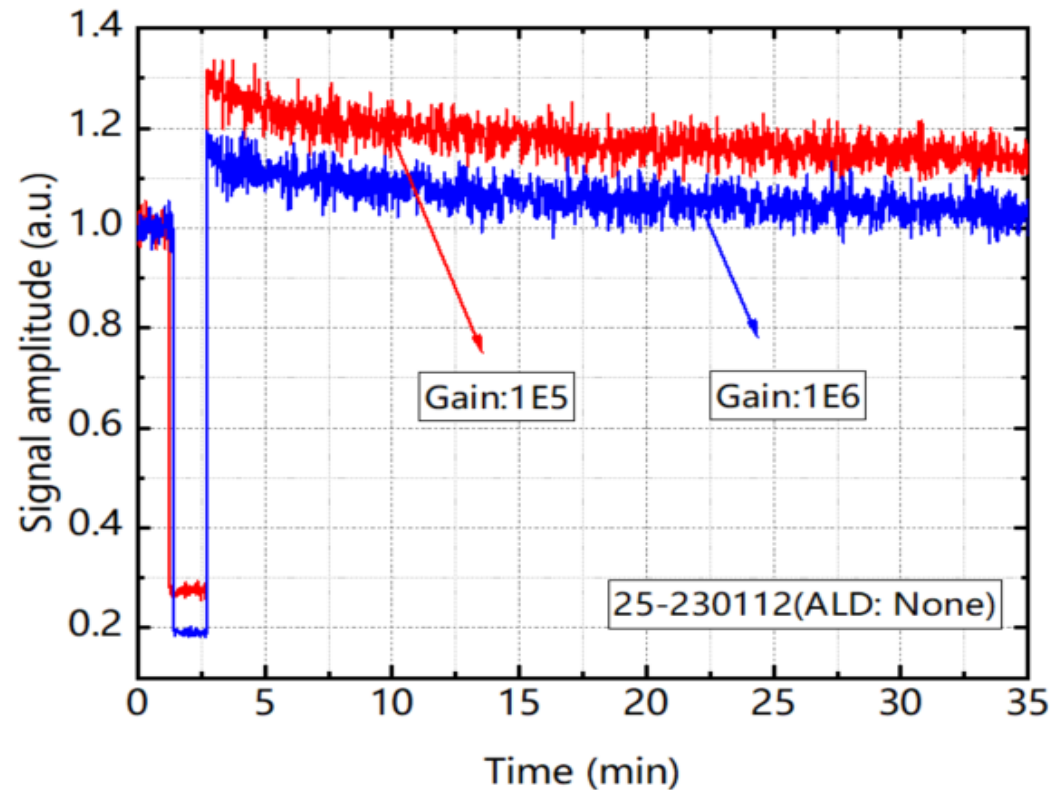
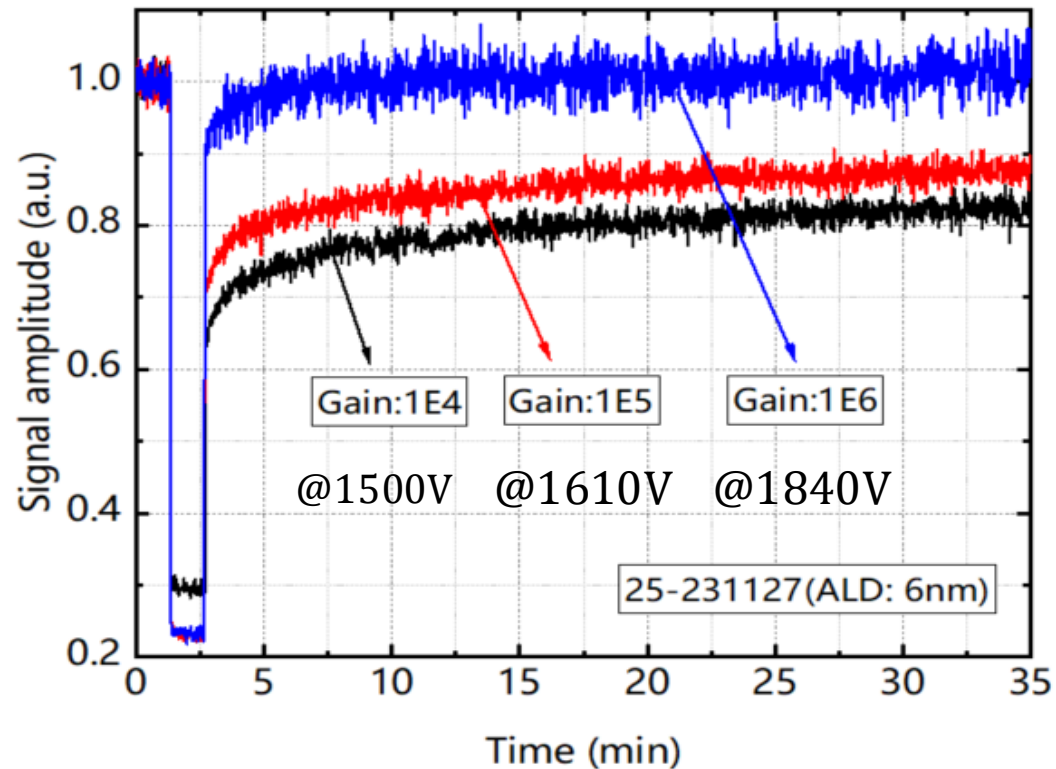


Recovery behavior



Supply voltage effect

- Higher supply voltage is better for recovery for the ALD-MCP
- Super linearity is less for higher HV



Summary & outlook



- ❑ ALD film on lead glass MCP is efficient for improve the lifetime.
- ❑ Increasing scrubbing amount for MCP is also good for lifetime.
- ❑ Thicker ALD-MCP has longer recovery time.
- ❑ The ALD film should be optimized considering the gain, lifetime and rate capability.
- ❑ Super linearity is found in the non ALD-MCP, which needs to be studied further.
- ❑ Higher supply voltage seems better for gain recovery.
- ❑ The ALD-film and scrubbing amount for MCP will be optimized for improving lifetime further.
- ❑ The single photon rate capability will be evaluated.



Thank you for your attention !